

Report No. MCR-22-0606 September 01,2022

RENESAS SEMICONDUCTOR RELIABILITY REPORT

GROUP: RL78/G1A

DEVICE : R5F10EXXX

APPLICATION: Consumer / Industry

Quality Assurance Div. Renesas Electronics Corporation



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(Rev.5.0-2 October 2020)



Table. Reliability test results (QFP)

Test Items	Reference	Test Conditions	Results Failure/Size	Comment
High Temperature Operating Life (HTOL)	JESD22-A108	Ta=125 ℃, Vccmax, 1000 hrs	0/22	
High Temperature Storage Life (HTSL)	JESD22-A103	Ta=150 ℃, 1000 hrs	0/22	
Temperature Humidity bias (THB) (*1)	JESD22-A101	Ta=85 ℃, RH=85 %, Vccmax, 1000 hrs	0/22	
Temperature Cycling (TC) (*1)	JESD22-A104	Ta=-65 $^{\circ}$ C to 150 $^{\circ}$ C , 300 cycles	0/22	
Latch-Up (LU)	JESD78 Pulse Current Injection, I=+/-150 mA		0/3	
Electrostatic discharge (ESD-HBM)	JS-001	1.5 kΩ, 100 pF, +/-2000 V, 1 time	0/3	Class: 2
Electrostatic discharge (ESD-CDM)	JESD22-C101	+/-500V,1time	0/3	Class: C2
Solderability (SD)	J-STD-002	245 ℃, 5 s, Solder coverage ≥95 %	0/5	
Resistance to Soldering Heat (PC)	JESD22-A113, J-STD-020	MSL3(Moisture Sensitivity Level 3)	0/22	

Basically qualification tests were performed using a representative product with the same wafer process and the same package structure .

^{*1)} With preconditioning per JESD22-A113, MSL 3
•It is tested to confirm that all the samples are satisfied with an individual product specification.



Table. Reliability test results (QFN)

Test Items	Reference	Test Conditions	Results Failure/Size	Comment
High Temperature Operating Life (HTOL)	JESD22-A108	Ta=125 ℃, Vccmax, 1000 hrs	0/22	
High Temperature Storage Life (HTSL)	JESD22-A103	Ta=150 ℃, 1000 hrs	0/22	
Temperature Humidity bias (THB) (*1)	JESD22-A101	Ta=85 ℃, RH=85 %, Vccmax, 1000 hrs	0/22	
Temperature Cycling (TC) (*1)	JESD22-A104	Ta=-65 $^{\circ}$ C to 150 $^{\circ}$ C , 300 cycles	0/22	
Latch-Up (LU)	JESD78 Pulse Current Injection, I=+/-150 m		0/3	
Electrostatic discharge (ESD-HBM)	JS-001	1.5 kΩ, 100 pF, +/-2000 V, 1 time	0/3	Class: 2
Electrostatic discharge (ESD-CDM)	JESD22-C101	+/-500V,1time	0/3	Class: C2
Solderability (SD)	J-STD-002	245 ℃, 5 s, Solder coverage ≥95 %	0/5	
Resistance to Soldering Heat (PC)	JESD22-A113, J-STD-020	MSL3(Moisture Sensitivity Level 3)	0/22	

Basically qualification tests were performed using a representative product with the same wafer process and the same package structure .

^{*1)} With preconditioning per JESD22-A113, MSL 3
•It is tested to confirm that all the samples are satisfied with an individual product specification.



Table. Reliability test results (BGA)

Test Items	Reference	Test Conditions	Results Failure/Size	Comment
High Temperature Operating Life (HTOL)	JESD22-A108	Ta=125 ℃, Vccmax, 1000 hrs	0/22	
High Temperature Storage Life (HTSL)	JESD22-A103	Ta=150 ℃, 1000 hrs	0/22	
Temperature Humidity bias (THB) (*1)	JESD22-A101	Ta=85 ℃, RH=85 %, Vccmax, 1000 hrs	0/22	
Temperature Cycling (TC) (*1)	JESD22-A104	Ta=-55 $^{\circ}$ to 125 $^{\circ}$, 500 cycles	0/22	
Latch-Up (LU)	$I = IFSI / 8$ Pulse (urrent Injection $I = \pm / -150$) ma		0/3	
Electrostatic discharge (ESD-HBM)	JS-001	1.5 kΩ, 100 pF, +/-2000 V, 1 time	0/3	Class: 2
Electrostatic discharge (ESD-CDM)	JESD22-C101	+/-500V,1time	0/3	Class: C2
Resistance to Soldering Heat (PC)	JESD22-A113, J-STD-020	MSL3(Moisture Sensitivity Level 3)	0/22	

^{*1)} With preconditioning per JESD22-A113, MSL 3

Note:

Basically qualification tests were performed using a representative product with the same wafer process and the same package structure .

[•]It is tested to confirm that all the samples are satisfied with an individual product specification.



Table. Reliability test results (LGA)

Test Items	Reference	Test Conditions	Results Failure/Size	Comment
High Temperature Operating Life (HTOL)	JESD22-A108	Ta=125 ℃, Vccmax, 1000 hrs	0/22	
High Temperature Storage Life (HTSL)	JESD22-A103	Ta=150 ℃, 1000 hrs	0/22	
Temperature Humidity bias (THB) (*1)	JESD22-A101	Ta=85 ℃, RH=85 %, Vccmax, 1000 hrs	0/22	
Temperature Cycling (TC) (*1)	JESD22-A104	Ta=-55 $^{\circ}$ to 125 $^{\circ}$, 500 cycles	0/22	
Latch-Up (LU)	$I = IFSI / 8$ Pulse (urrent Injection $I = \pm / -150$) ma		0/3	
Electrostatic discharge (ESD-HBM)	JS-001	1.5 kΩ, 100 pF, +/-2000 V, 1 time	0/3	Class: 2
Electrostatic discharge (ESD-CDM)	JESD22-C101	+/-500V,1time	0/3	Class: C2
Resistance to Soldering Heat (PC)	JESD22-A113, J-STD-020	MSL3(Moisture Sensitivity Level 3)	0/22	

^{*1)} With preconditioning per JESD22-A113, MSL 3

Note:

 $Basically\ qualification\ tests\ were\ performed\ using\ a\ representative\ product\ with\ the\ same\ wafer\ process\ and\ the\ same\ package\ structure\ .$

[•]It is tested to confirm that all the samples are satisfied with an individual product specification.

The failure rate of the device in an actual use condition can be estimated by the below procedure.

•Equation for the failure rate estimation (λ)

$$\lambda = \lambda b \times \pi T$$
 (FIT)

①Unique failure rate (λb)

$$\lambda b = 3.8 \text{ FIT}$$

Unique failure rate at Ta=55 ℃ using 60 % confidence level.

②Temperature term (π T)

$$\pi T = \exp\{11600 \times Ea \times (1/(273+55)-1/(273+Ta))\}$$

Ea: Activation energy (eV)
Ta: Ambient temperature (℃)

π T simplified chart as Ea=0.7 eV												
Ta (℃)	40	50	55	60	65	70	75	80	85	90	100	110
πТ	0.31	0.68	1	1.45	2.08	2.95	4.15	5.77	7.96	10.88	19.82	34.99

·MTTF (Mean Time To Failure)

$$MTTF = 1/\lambda$$



Reference about Renesas package code

Package type		Package code *1
Lead type plastic package	QFP	PxQP
	SOP	PxSP
Non-lead type plastic package	QFN	PxQN
Grid array type plastic package	BGA	PxBG
	LGA	PxLG

^{*1.} First four digit

Table. Product list

Table	e. Product lis	it					
No	Group	Product part number	Package code	No	Group	Product part number	Package code
1	RL78/G1A	R5F10E8AALA	PWLG0025K*	51			
2	RL78/G1A	R5F10E8AGLA	PWLG0025K*	52			
3	RL78/G1A	R5F10E8CALA	PWLG0025K*	53			
4	RL78/G1A	R5F10E8CGLA	PWLG0025K*	54			
5	RL78/G1A	R5F10E8DALA	PWLG0025K*	55			
6	RL78/G1A	R5F10E8DGLA	PWLG0025K*	56			
7	RL78/G1A	R5F10E8EALA	PWLG0025K*	57			
8	RL78/G1A	R5F10E8EGLA	PWLG0025K*	58			
9	RL78/G1A	R5F10EBAANA	PWQN0032K*	59			
10	RL78/G1A	R5F10EBAGNA	PWQN0032K*	60			
11	RL78/G1A	R5F10EBCANA	PWQN0032K*	61			
12	RL78/G1A	R5F10EBCGNA	PWQN0032K*	62			
13	RL78/G1A	R5F10EBDANA	PWQN0032K*	63			
14	RL78/G1A	R5F10EBDGNA	PWQN0032K*	64			
15	RL78/G1A	R5F10EBEANA	PWQN0032K*	65			
16	RL78/G1A	R5F10EBEGNA	PWQN0032K*	66			
17	RL78/G1A	R5F10EGAAFB	PLQP0048K*	67			
18	RL78/G1A	R5F10EGAANA	PWQN0048K*	68			
19	RL78/G1A	R5F10EGAGFB	PLQP0048K*	69			
20	RL78/G1A	R5F10EGAGNA	PWQN0048K*	70			
21	RL78/G1A	R5F10EGCAFB	PLQP0048K*	71			
22	RL78/G1A	R5F10EGCANA	PWQN0048K*	72			
23	RL78/G1A	R5F10EGCGFB	PLQP0048K*	73			
24	RL78/G1A	R5F10EGCGNA	PWQN0048K*	74			
25	RL78/G1A	R5F10EGDAFB	PLQP0048K*	75			
26	RL78/G1A	R5F10EGDANA	PWQN0048K*	76			
27	RL78/G1A	R5F10EGDGFB	PLQP0048K*	77			
28	RL78/G1A	R5F10EGDGNA	PWQN0048K*	78			
29	RL78/G1A	R5F10EGEAFB	PLQP0048K*	79			
30	RL78/G1A	R5F10EGEANA	PWQN0048K*	80			
31	RL78/G1A	R5F10EGEGFB	PLQP0048K*	81			
32	RL78/G1A	R5F10EGEGNA	PWQN0048K*	82			
33	RL78/G1A	R5F10ELCABG	PVBG0064L*	83			
34	RL78/G1A	R5F10ELCAFB	PLQP0064K*	84			
35	RL78/G1A	R5F10ELCGBG	PVBG0064L*	85			
36	RL78/G1A	R5F10ELCGFB	PLQP0064K*	86			
37	RL78/G1A	R5F10ELDABG	PVBG0064L*	87			
38	RL78/G1A	R5F10ELDAFB	PLQP0064K*	88			
39	RL78/G1A	R5F10ELDGBG	PVBG0064L*	89			
40	RL78/G1A	R5F10ELDGFB	PLQP0064K*	90			
41	RL78/G1A	R5F10ELEABG	PVBG0064L*	91			
42	RL78/G1A	R5F10ELEAFB	PLQP0064K*	92			
43	RL78/G1A	R5F10ELEGBG	PVBG0064L*	93			
44	RL78/G1A	R5F10ELEGFB	PLQP0064K*	94			
45			1-2	95			
46	1			96			
47	 	1		97			
48	 			98			
49	†			99			
50	 						
50				100			